



# SCE Time Dependence Study using Beam Electrons/Protons

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ProtoDUNE Sim/Reco Meeting February 20<sup>th</sup>, 2019



#### Introduction



- ◆ Aaron presented a study of beam electrons (e<sup>+</sup>) in the Thursday ProtoDUNE Analysis meeting
  - See slides here
- ◆ This is a useful sample for detector calibration can use to probe time dependence of SCE
  - Look at width of  $\Delta Z$  distribution in data, compare to MC
  - Broadening in MC due only to reconstruction effects
  - Broadening in data due to reconstruction and SCE
  - Also study  $\Delta Z$  bias/resolution in X-Y plane
- ♦ Aaron also provided sample of protons repeat study
- ◆ This study is to be complemented with cosmics-based time dependence study (Francesca)
  - Cosmics-based study opens up other parts of TPC





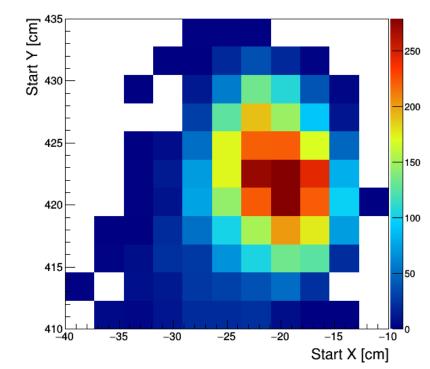
# Electrons



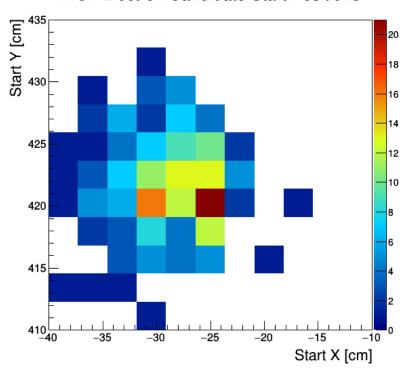
# Samples/Coverage



Data: Electron Candidate Start Positions



MC: Electron Candidate Start Positions

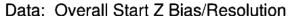


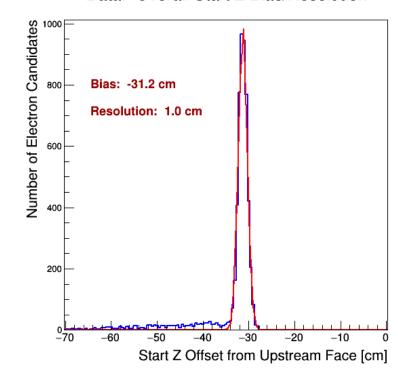
- ♦ Data: Run 5809
  - Number of e<sup>+</sup> candidates: 5930
- ♦ MC: 1 GeV e<sup>+</sup> beam MC
  - Number of e<sup>+</sup> candidates: **240** (can we get more?)



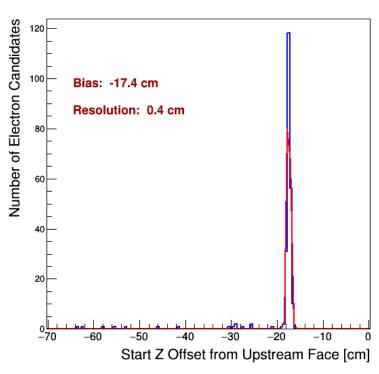
#### Gaussian Fits







#### MC: Overall Start Z Bias/Resolution

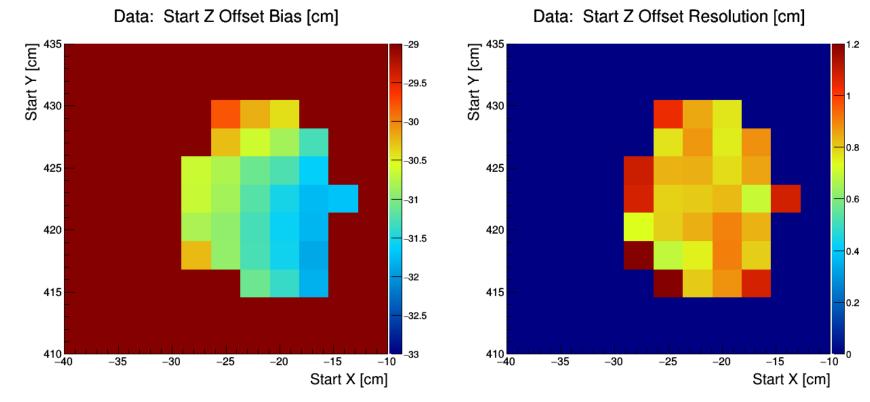


- Look at total Z offset distribution (all e+ candidates)
  - Data:  $-31.2 \pm 1.0$  cm
  - MC:  $-17.4 \pm 0.4$  cm
- ♦ Implies SCE time dependence ~ 1 cm (3% effect)



## Bias/Resolution in Data





- Study dependence of bias/resolution in X-Y plane
  - Fit to Gaussian only if > 40 candidates in bin, data only
- ◆ See expected variation in X-Y plane for bias (SCE worse near cathode), relatively constant resolution





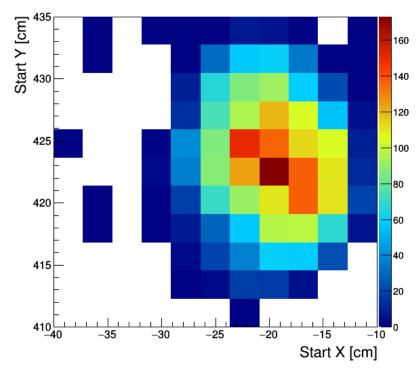
# Protons



# Sample/Coverage







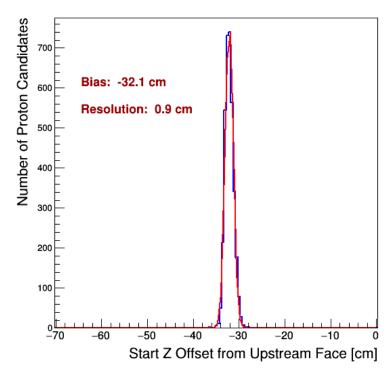
- ♦ Data: Run 5387
  - Number of p candidates: 3542
- ◆ **No MC** sample provided for this run
  - Can be produced, of course...



#### Gaussian Fit



Data: Overall Start Z Bias/Resolution

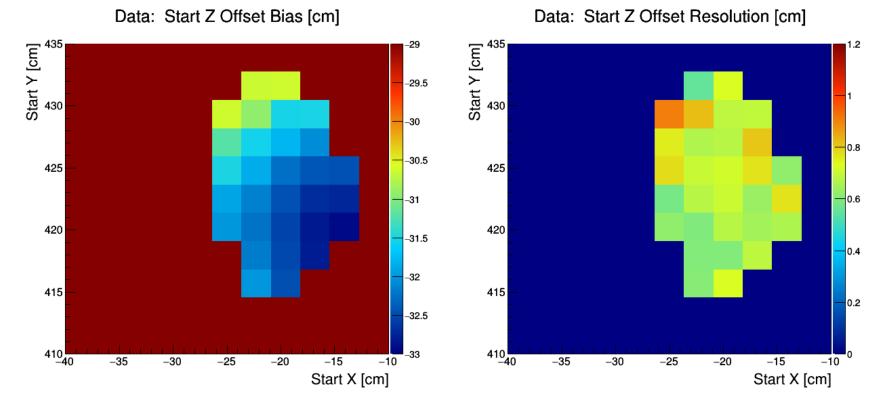


- ♦ Look at total Z offset distribution (all p candidates)
  - Data:  $-32.1 \pm 0.9$  cm
- ♦ Similar resolution as for electrons sample, but bias is different by ~1 cm (-32.1 cm vs. -31.2 cm)



#### Bias/Resolution in Data





- ♦ Study dependence of bias/resolution in X-Y plane
  - Fit to Gaussian only if > 40 candidates in bin
- ◆ Similar conclusions as for case of electrons (expected distributions), though bias is worse by ~1 cm

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# Conclusions/Discussion



- Using beam electrons/protons samples prepared by Aaron, studied SCE time dependence
  - Can only study SCE where beam enters upstream TPC face with this analysis
- ◆ Appears to be ~1 cm variation in SCE over time
  - Roughly 3% of total SCE spatial distortion (~ 30 cm)
  - Reconstruction resolution of roughly 0.4 cm (~ 1 wire)
- ♦ Similar effect observed at MicroBooNE (roughly 5% variation in SCE over time)
- ◆ Need to study SCE time dependence over entire TPC
  - Cosmics-based analysis by Francesca O(hours)
  - <sup>39</sup>Ar-based analysis by Alex Flesher O(minutes)



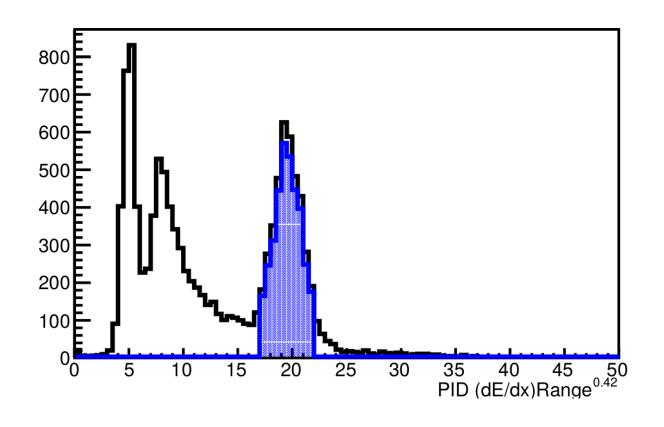


# BACKUP SLIDES



## Proton Selection





◆ Aaron uses PID cut to select proton candidates (see above plot)